# **Power MOSFET**

40 V, 7.5 A, 25 m $\Omega$ 

## **Features**

- Low R<sub>DS(on)</sub>
- Low Capacitance
- Optimized Gate Charge
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	40	V
Gate-to-Source Volta	age		$V_{GS}$	±20	V
Continuous Drain Current R <sub>0.1A</sub>		T <sub>A</sub> = 25°C	I <sub>D</sub>	5.8	Α
(Note 1)	Steady	T <sub>A</sub> = 70°C		4.6	
Power Dissipation	State	T <sub>A</sub> = 25°C	$P_{D}$	1.5	W
R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 70°C	1	1.0	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	7.5	Α
Current R <sub>θJA</sub> (Note 1)	t ≤10 s	T <sub>A</sub> = 70°C		6.0	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	2.6	W
R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 70°C		1.6	
Pulsed Drain Current	t <sub>p</sub> = 10 μs		I <sub>DM</sub>	30	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	7.5	Α
Single Pulse Drain-to-Source Avalanche			EAS	20	mJ
Energy (V <sub>DD</sub> = 40 V, V <sub>GS</sub> = 10 V, L = 0.1 mH)			IAS	20	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient Steady State (Note 1)	$R_{\theta JA}$	83	
Junction-to-Ambient - t ≤10 s (Note 1)	$R_{\theta JA}$	49	°C/W
Junction-to-Foot (Drain) (Note 1)	$R_{\theta JF}$	22	-0/00
Junction-to-Ambient Steady State (Note 2)	$R_{\theta JA}$	123	

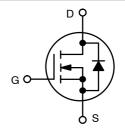
- Surface-mounted on FR4 board using 1 sq-in pad (Cu area = 1.127 in sq [2 oz] including traces).
- 2. Surface-mounted on FR4 board using 0.155 in sq (100mm<sup>2</sup>) pad size.



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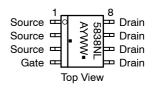
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX	
40 V	25 mΩ @ 10 V	7.5 A	
40 V	30.8 m $\Omega$ @ 4.5 V	7.5 K	



**N-CHANNEL MOSFET** 

## MARKING DIAGRAM/ PIN ASSIGNMENT





A = Assembly Location

Y = Year WW = Work Week • Pb-Free Package\*

(\*Note: Microdot may be in either location)

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMS5838NLR2G	SO-8 (Pb-Free)	2500/Tape & Reel

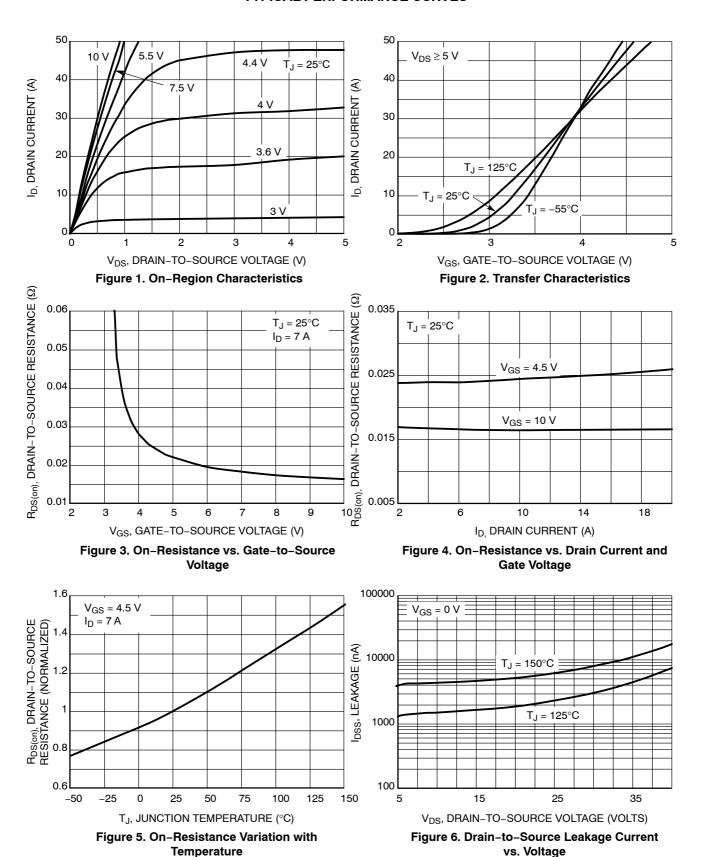
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

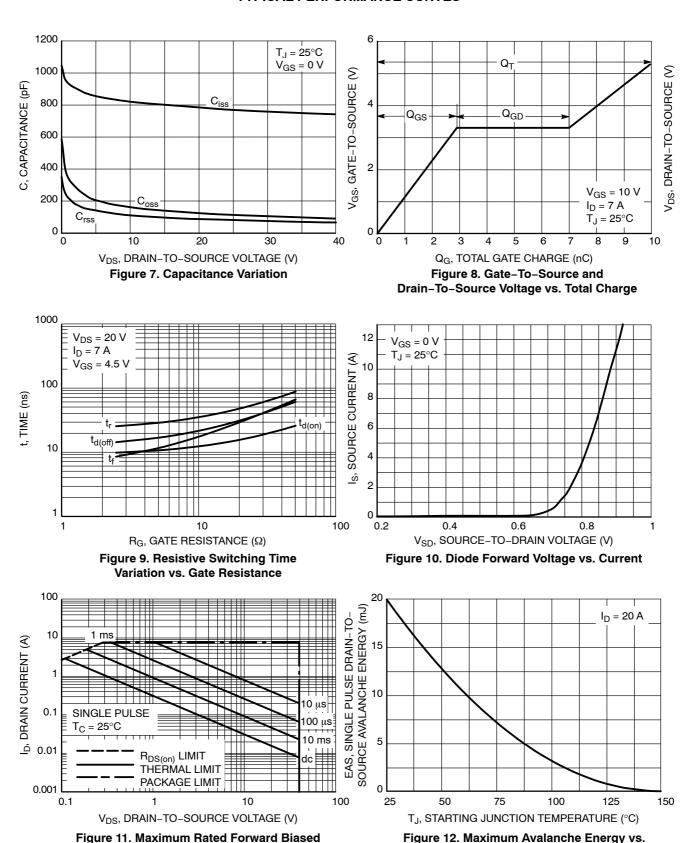
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				32		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25°C			1	
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.0	1.8	3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>E</sub>	<sub>0</sub> = 7 A		20.5	25	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>I</sub>	<sub>D</sub> = 7 A		25.0	30.8	
Forward Transconductance	9FS	V <sub>DS</sub> = 15 V, I <sub>E</sub>	<sub>0</sub> = 7 A		4.0		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						
Input Capacitance	C <sub>ISS</sub>				785		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz	z, V <sub>DS</sub> = 20 V		123		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				90		1
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 20 V; I <sub>D</sub> = 7 A			17		
					8.6	11	1
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.8		nC
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 2$	20 V; I <sub>D</sub> = 7 A		2.8		1
Gate-to-Drain Charge	$Q_{GD}$				4.0		1
Plateau Voltage	V <sub>GP</sub>				3.2		V
Gate Resistance	R <sub>G</sub>				1.8		Ω
SWITCHING CHARACTERISTICS (Note 4)						•	•
Turn-On Delay Time	t <sub>d(ON)</sub>				11		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub>	s = 20 V.		23		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 20 \text{ V},$ $I_{D} = 7 \text{ A}, R_{G} = 2.5 \Omega$			17		ns -
Fall Time	t <sub>f</sub>				4.0		
DRAIN-SOURCE DIODE CHARACTERISTIC	s				1		•
Forward Diode Voltage	$V_{SD}$	Vce = 0 V.	T <sub>J</sub> = 25°C		0.84	1.2	
		$V_{GS} = 0 V$ , $I_S = 7 A$	T <sub>J</sub> = 125°C		0.7		<b>-</b>
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 7 \text{ A}$			17		
Charge Time	ta				11		ns
Discharge Time	t <sub>b</sub>				6.0		1
Reverse Recovery Charge	Q <sub>RR</sub>				10		nC

<sup>3.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

## TYPICAL PERFORMANCE CURVES



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**Starting Junction Temperature** 

Safe Operating Area

# **TYPICAL PERFORMANCE CURVES**

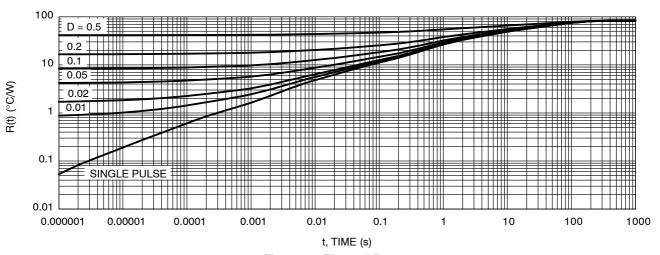
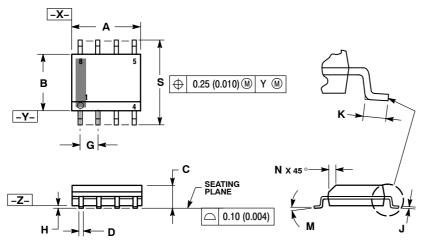


Figure 13. Thermal Response

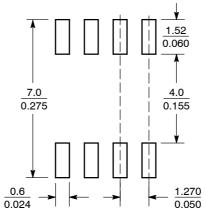
#### PACKAGE DIMENSIONS

## SOIC-8 NB CASE 751-07 **ISSUE AK**



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#### **SOLDERING FOOTPRINT\***



(mm inches SCALE 6:1

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION A AND B DO NOT INCLUDE
- MOLD PROTRUSION.
  MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- PER SIDE.
  DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIN	IETERS	INC	HES		
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
С	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		050 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
M	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

#### STYLE 12:

- PIN 1. SOURCE
  - SOURCE 2. SOURCE

  - GATE DRAIN 5.
  - DRAIN
  - DRAIN
  - 8. DRAIN

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